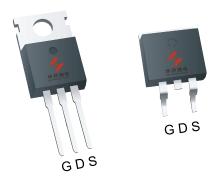


N-Channel Enhancement Mode MOSFET

Feature

- 80V/200A $R_{DS(ON)}$ = 2.6 $m\Omega(typ.)$ @VGS = 10V
- 100% Avalanche Tested
- 100% DVDS
- Reliable and Rugged
- Halogen Free and Green Devices Available (RoHS Compliant)

Pin Description

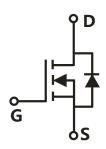


TO-220FB-3L

TO-263-2L

Applications

- Switching application
- Li-battery protection
- Motor control



Single N-Channel MOSFET

Ordering and Marking Information



Note: HUAYI halogen free products contain molding compounds and 100% matter tin plate Termi-Nation finish; which are fully compliant with RoHS. HUAYI halogen free products meet or exceed the halogen free require-ments of IPC/JEDEC J-STD-020 for MSL classification at halogen free peak reflow temperature. HUAYI defines "Green" to mean halogen free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Ra	ntings (Tc=25°C Unless Otherwise Noted)		,	1
VDSS	Drain-Source Voltage		80	V
Vgss	Gate-Source Voltage		±20	V
TJ	Junction Temperature Range			°C
Тѕтс	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode) Tc=25°C		200	А
Mounted on	Large Heat Sink		•	
Ірм	Pulsed Drain Current *	Tc=25°C	600	А
	Continuous Danie Comment	Tc=25°C	200	А
lo	Continuous Drain Current	Tc=100°C	141.4	А
		Tc=25°C	258.6	W
Pb	Maximum Power Dissipation Tc=100°C		129.3	W
R₀c	Thermal Resistance, Junction-to-Case		0.58	°C/W
R _{eJA}	Thermal Resistance, Junction-to-Ambient	Thermal Resistance, Junction-to-Ambient **		°C/W
Eas	Single Pulsed-Avalanche Energy *** L=0.3mH		688	mJ

Note:

- * Repetitive rating; pulse width limited by max.junction temperature.
- ** Surface mounted on 1in2 FR-4 board.
- *** Limited by TJmax , starting TJ=25°C, L = 0.3mH, Rg= 25Ω , Vgs =10V.

Electrical Characteristics(Tc =25°C Unless Otherwise Noted)

Complete	Barrantan	Took Conditions	HYG026N08NS1			11
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Static Cha	racteristics					
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250μA	80	-	-	V
Durinta Communications Communication		Vps=80V,Vgs=0V	-	-	1	μA
Ibss Drain-to-Source Lea	Drain-to-Source Leakage Current	TJ=125°C	-	-	50	μA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250µA	2.2	3	3.8	V
lgss	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	±100	nA
RDS(ON)	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =50A	-	2.6	3.1	mΩ
Diode Cha	racteristics					
VsD	Diode Forward Voltage	Isp=50A,Vgs=0V	-	0.87	1.2	V
trr	Reverse Recovery Time	Ica-FOA dica/dt-100A/ug	-	51	-	ns
Qrr	Reverse Recovery Charge	- IsD=50A,dIsD/dt=100A/μs	-	71	-	nC

HYG026N08NS1P/B



Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

O. mala al	Barrantan	Took Conditions	HY	HYG026N08NS1		
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Dynamic	Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=500KHz	-	1.3	-	Ω
Ciss	Input Capacitance	V _G S=0V,	-	7782	-	
Coss	Output Capacitance	Vps=25V,	-	1835	-	pF
Crss	Reverse Transfer Capacitance	Frequency=500KHz	-	76	-	
td(ON)	Turn-on Delay Time		-	25	-	
Tr	Turn-on Rise Time	$V_{DD}=40V,R_{G}=2.5\Omega,$	-	84	-	
td(OFF)	Turn-off Delay Time	Ips=50A,Vgs=10V	-	50	-	ns
Tf	Turn-off Fall Time		-	91	-	
Gate Char	rge Characteristics		•			
Qg	Total Gate Charge(V _{GS} =10V)		-	107	-	
Qgs	Gate-Source Charge	\/ _64\/ _504	-	40	-	nC
Qgd	Gate-Drain Charge	V_{DS} =64V, I_{DS} =50A	-	13	-	
V _{plateau}	Gate plateau voltage		-	5	-	V

Note: *Pulse test, pulse width ≤ 300 us, duty cycle $\leq 2\%$



Typical Operating Characteristics

Figure 1: Power Dissipation

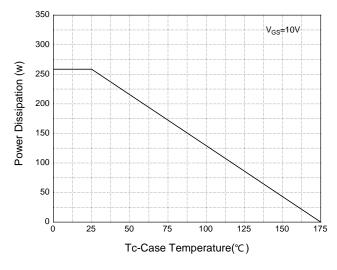


Figure 2: Drain Current

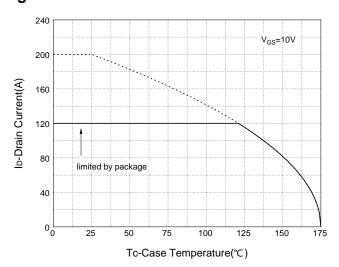


Figure 3: Safe Operation Area

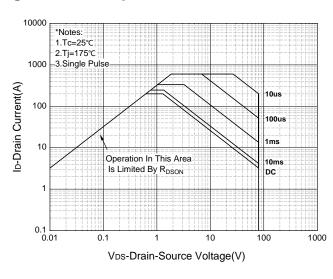


Figure 4: Thermal Transient Impedance

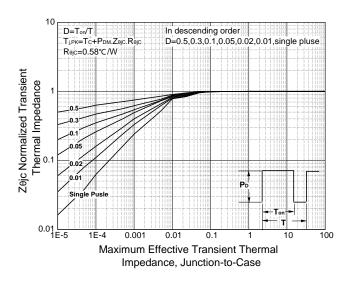


Figure 5: Output Characteristics

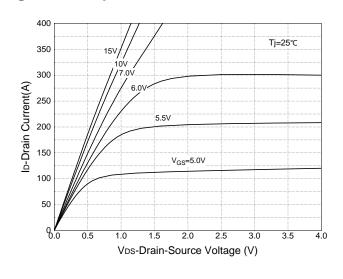
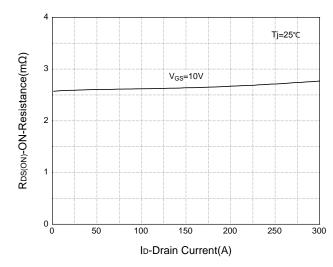


Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

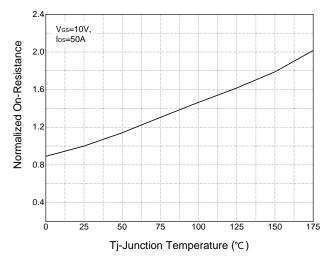


Figure 8: Source-Drain Diode Forward

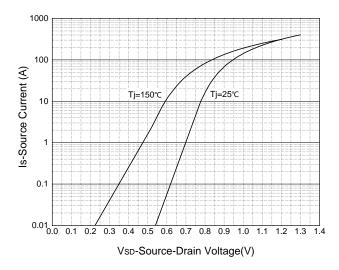


Figure 9: Capacitance Characteristics

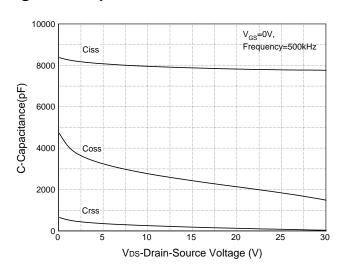
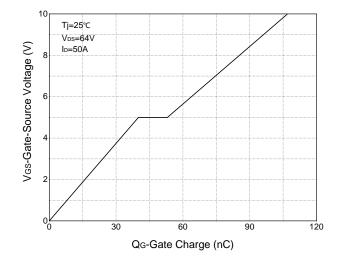
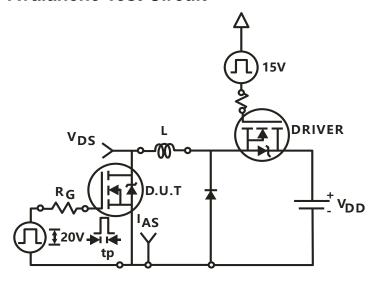


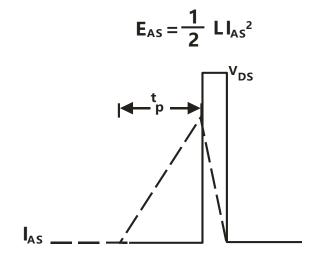
Figure 10: Gate Charge Characteristics



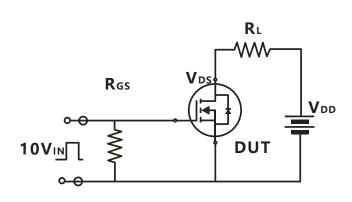


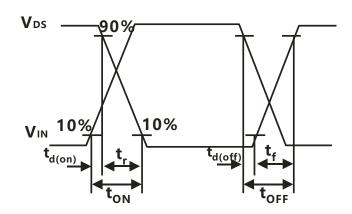
Avalanche Test Circuit



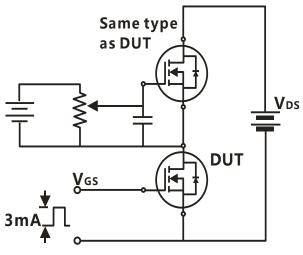


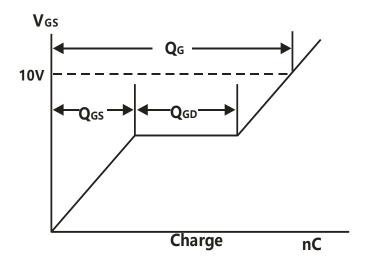
Switching Time Test Circuit





Gate Charge Test Circuit





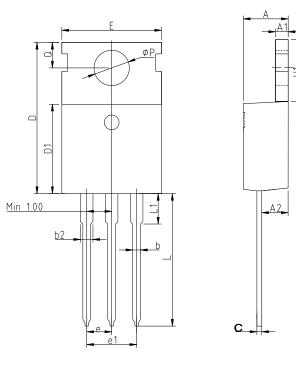


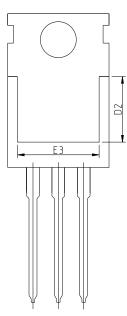
Device Per Unit

Package Type	Unit	Quantity
TO-220FB-3L	Tube	50
TO-263-2L	Reel	800

Package Information

TO-220FB-3L

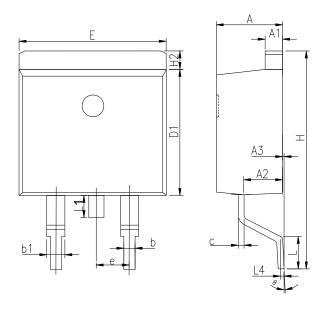


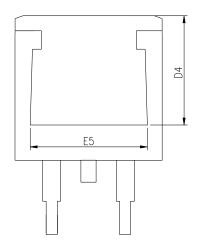


COMMON DIMENSIONS				
0)/////	mm			
SYMBOL	MIN	NOM	MAX	
Α	4.37	4.57	4.77	
A1	1.25	1.30	1.40	
A2	2.20	2.40	2.60	
b	0.70	0.80	0.95	
b2	1.17	1.27	1.47	
С	0.45	0.50	0.60	
D	15.10	15.60	16.10	
D1	8.80	9.10	9.40	
D2	5.50	6.30	7.10	
Е	9.70	10.00	10.30	
E3	7.00	7.80	8.60	
е	2.54 BSC			
e1		5.08 BSC		
H1	6.25	6.50	6.85	
L	12.75	13.50	13.80	
L1	-	3.10	3.40	
ФР	3.40	3.60	3.80	
Q	2.60	2.80	3.00	



TO-263-2L

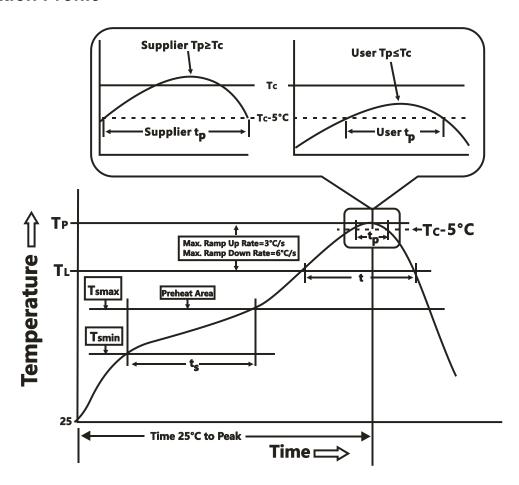




COMMON DIMENSIONS					
SYMBOL		mm			
STIVIBUL	MIN	NOM	MIN		
Α	4.37	4.57	4.77		
A1	1.22	1.27	1.42		
A2	2.49	2.69	2.89		
A3	0	0.13	0.25		
b	0.70	0.81	0.96		
b1	1.17	1.27	1.47		
С	0.30	0.38	0.53		
D1	8.50	8.70	8.90		
D4	6.60	-	-		
Е	9.86	10.16	10.36		
E5	7.06	-	-		
е		2.54 BSC			
Н	14.70	15.10	15.50		
H2	1.07	1.27	1.47		
L	2.00	2.30	2.60		
L1	1.40	1.55	1.70		
L4		0.25 BSC			
θ	0° 5° 9°				



Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly	
	Preheat & Soak		
Temperature min (T _{smin})	100 °C	150 °C	
Temperature max (T _{smax})	150 °C	200 °C	
Time (Tsmin to Tsmax) (t _s)	60-120 seconds	60-120 seconds	
Average ramp-up rate	3 °C/second max.	3°C/second max.	
(T _{smax} to T _P)	5 C/second max.		
Liquidous temperature (T _L)	183 °C	217 °C	
Time at liquidous (t _L)	60-150 seconds	60-150 seconds	
Peak package body Temperature	See Classification Temp in table 1	SacClassification Tampin table 2	
(T _p)*	See Classification Temp in table 1	SeeClassification Tempin table 2	
Time (t _P)** within 5°C of the specified	20** accords	30** seconds	
classification temperature (T _c)	20** seconds	30 seconds	
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.	
Time 25°C to peak temperature	6 minutes max.	8 minutes max.	

^{*}Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.

HYG026N08NS1P/B



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm³ <350	Volume mm³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm ³	Volume mm ³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102 5 Sec, 245°C	
HTRB	JESD-22, A108	168/500 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 /500 Hrs, Vgs100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	250/500 Cycles, -55°C~150°C

Customer Service

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